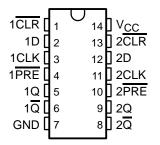
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- AC Types Feature 1.5-V to 5.5-V Operation and Balanced Noise Immunity at 30% of the Supply
- Speed of Bipolar F, AS, and S, With Significantly Reduced Power Consumption
- **Balanced Propagation Delays**
- ±24-mA Output Drive Current Fanout to 15 F Devices
- SCR-Latchup-Resistant CMOS Process and **Circuit Design**
- **Exceeds 2-kV ESD Protection Per** MIL-STD-883, Method 3015

CD54AC74...F PACKAGE CD74AC74...E OR M PACKAGE (TOP VIEW)



description/ordering information

The 'AC74 dual positive-edge-triggered devices are D-type flip-flops.

A low level at the preset (PRE) or clear (CLR) inputs sets or resets the outputs, regardless of the levels of the other inputs. When PRE and CLR are inactive (high), data at the data (D) input meeting the setup time requirements is transferred to the outputs on the positive-going edge of the clock pulse. Clock triggering occurs at a voltage level and is not related directly to the rise time of the clock pulse. Following the hold-time interval, data at the D input can be changed without affecting the levels at the outputs.

ORDERING INFORMATION

TA	PACKA	GE†	ORDERABLE PART NUMBER	TOP-SIDE MARKING
	PDIP – E	Tube	CD74AC74E	CD74AC74E
–55°C to 125°C	SOIC – M	Tube	CD74AC74M	AC74M
-55 C to 125 C	SOIC - W	Tape and reel	CD74AC74M96	AC74IVI
	CDIP – F	Tube	CD54AC74F3A	CD54AC74F3A

[†] Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

FUNCTION TABLE (each flip-flop)

	INP	UTS		OUTI	PUTS
PRE	CLR	CLK	D	Q	Q
L	Н	Х	Χ	Н	L
Н	L	X	Χ	L	Н
L	L	X	Χ	н‡	н‡
Н	Н	\uparrow	Н	Н	L
Н	Н	\uparrow	L	L	Н
Н	Н	L	Χ	Q_0	\overline{Q}_0

[‡] This configuration is nonstable; that is, it does not persist when PRE or CLR returns to its inactive (high) level.



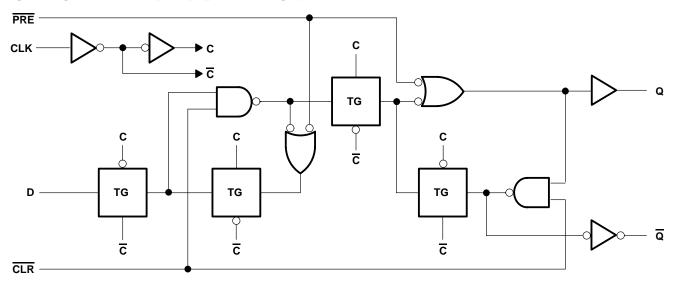
testing of all parameters.

Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.



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logic diagram, each flip-flop (positive logic)



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, V _{CC}	0.5 V to 6 V
Input clamp current, I _{IK} (V _I < 0 or V _I > V _{CC}) (see Note 1)	
Output clamp current, I _{OK} (V _O < 0 or V _O > V _{CC}) (see Note 1)	±50 mA
Continuous output current, I_O ($V_O = 0$ to V_{CC})	$\dots \dots \pm 50 \text{ mA}$
Continuous current through V _{CC} or GND	$\dots \dots \pm 100 \ mA$
Package thermal impedance, θ _{JA} (see Note 2): E package	80°C/W
M package	86°C/W
Storage temperature range, T _{stq}	\dots -65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.
 - 2. The package thermal impedance is calculated in accordance with JESD 51-7.



recommended operating conditions (see Note 3)

			T _A = 25°C		–40°C to 85°C		UNIT		
			MIN	MAX	MIN	MAX	MIN	MAX	
Vсс	Supply voltage		1.5	5.5	1.5	5.5	1.5	5.5	V
		V _{CC} = 1.5 V	1.2		1.2		1.2		
٧ıH	High-level input voltage	V _{CC} = 3 V	2.1		2.1		2.1		V
		V _{CC} = 5.5 V	3.85		3.85		3.85		
		V _{CC} = 1.5 V		0.3		0.3		0.3	
VIL	Low-level input voltage	V _{CC} = 3 V		0.9		0.9		0.9	V
		V _{CC} = 5.5 V		1.65		1.65		1.65	
٧ _I	Input voltage		0	VCC	0	VCC	0	VCC	V
۷o	Output voltage		0	VCC	0	VCC	0	VCC	V
ІОН	High-level output current	V _{CC} = 4.5 V to 5.5 V		-24		-24		-24	mA
loL	Low-level output current	$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$		24		24		24	mA
Δt/Δν	Input transition rise or fall rate	$V_{CC} = 1.5 \text{ V to 3 V}$		50		50		50	ns/V
ΔψΔV	Input transition rise or fall rate	$V_{CC} = 3.6 \text{ V to } 5.5 \text{ V}$		20		20		20	115/V

NOTE 3: All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS		VCC	T _A = 25°C		–55°C to 125°C		–40°C to 85°C		UNIT		
				MIN	MAX	MIN	MAX	MIN	MAX			
			1.5 V	1.4		1.4		1.4				
		$I_{OH} = -50 \mu A$	3 V	2.9		2.9		2.9				
			4.5 V	4.4		4.4		4.4		1		
Voн	$V_I = V_{IH}$ or V_{IL}	$I_{OH} = -4 \text{ mA}$	3 V	2.58		2.4		2.48		V		
		$I_{OH} = -24 \text{ mA}$	4.5 V	3.94		3.7		3.8				
		$I_{OH} = -50 \text{ mA}^{\dagger}$	5.5 V			3.85						
		$I_{OH} = -75 \text{ mA}^{\dagger}$	5.5 V					3.85				
			1.5 V		0.1		0.1		0.1			
		Ι _Ο L = 50 μΑ	3 V		0.1		0.1		0.1			
			4.5 V		0.1		0.1		0.1			
V_{OL}	VI = VIH or VIL	$I_{OL} = 12 \text{ mA}$	3 V		0.36		0.5		0.44	V		
		$I_{OL} = 24 \text{ mA}$	4.5 V		0.36		0.5		0.44			
		$I_{OL} = 50 \text{ mA}^{\dagger}$	5.5 V				1.65					
		$I_{OL} = 75 \text{ mA}^{\dagger}$	5.5 V						1.65			
lį	$V_I = V_{CC}$ or GND		5.5 V		±0.1		±1		±1	μΑ		
ICC	$V_I = V_{CC}$ or GND,	IO = 0	5.5 V		4		80		40	μΑ		
Ci					10		10		10	pF		

[†] Test one output at a time, not exceeding 1-second duration. Measurement is made by forcing indicated current and measuring voltage to minimize power dissipation. Test verifies a minimum 50-Ω transmission-line drive capability at 85°C and 75-Ω transmission-line drive capability at 125°C.



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timing requirements over recommended operating free-air temperature range, $V_{CC} = 1.5 \text{ V}$ (unless otherwise noted)

			–55°(125		–40°C to 85°C		UNIT
			MIN	MAX	MIN	MAX	
fclock	Clock frequency			9		10	MHz
	Pulse duration	PRE or CLR low	50		44		ns
t _W	Pulse duration	CLK	56		49		115
	Catum time	Data	44		39		ns
t _{su}	Setup time	PRE or CLR inactive					ns
t _h	Hold time	Data after CLK↑	0		0		ns
t _{rec}	Recovery time, before CLK↑	CLR↑ or PRE↑	34	·	30		ns

timing requirements over recommended operating free-air temperature range, V_{CC} = 3.3 V \pm 0.3 V (unless otherwise noted) (see Figure 1)

				–55°C to 125°C		–40°C to 85°C	
			MIN	MAX	MIN	MAX	
fclock	Clock frequency			79		90	MHz
	Pulse duration	PRE or CLR low	5.6		4.9		ns
t _W	Pulse duration	CLK	6.3		5.5		115
	Catua tima	Data	4.9		4.3		ns
t _{su}	Setup time	PRE or CLR inactive					ns
th	Hold time	Data after CLK↑	0		0		ns
t _{rec}	Recovery time, before CLK↑	CLR↑ or PRE↑	4.7		4.1		ns

timing requirements over recommended operating free-air temperature range, V_{CC} = 5 V \pm 0.5 V (unless otherwise noted) (see Figure 1)

			–55°(125		–40°C to 85°C		UNIT
			MIN MA		MIN	MAX	
fclock	Clock frequency			110		125	MHz
	Pulse duration	PRE or CLR low	4		3.5		ns
t _W		CLK	4.5		3.9		
	Catura time	Data	3.5		3.1		ns
t _{su}	Setup time	PRE or CLR inactive					ns
t _h	Hold time	Data after CLK↑	0		0		ns
t _{rec}	Recovery time, before CLK↑	CLR↑ or PRE↑	2.7	·	2.4		ns

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switching characteristics over recommended operating free-air temperature range, V_{CC} = 1.5 V, C_L = 50 pF (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)				-55°C to -40°C to 125°C 85°C		UNIT
	(1141 01)	(0011 01)	MIN	MAX	MIN	MAX		
f _{max}			9		10		MHz	
t _{PLH}	01.14	Q or $\overline{\mathbb{Q}}$		125		114	no	
t _{PHL}	CLK			125		114	ns	
^t PLH	PRE or CLR	Q or $\overline{\mathbb{Q}}$		132		120	no	
t _{PHL}	PRE OF CLR	QorQ		144		131	ns	

switching characteristics over recommended operating free-air temperature range, V_{CC} = 3.3 V \pm 0.3 V (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	I TO I		–55°C to 125°C		–40°C to 85°C	
	(1141 01)	(0011 01)	MIN	MAX	MIN	MAX	
f _{max}			79		90		MHz
t _{PLH}	CLK	Q or $\overline{\mathbb{Q}}$	3.5	14	3.6	12.7	nc
t _{PHL}	CLK		3.5	14	3.6	12.7	ns
tPLH	PRE or CLR	Q or Q	3.7	14.7	3.8	13.4	ns
^t PHL	FRE UI CER	Q 01 Q	4	16.1	4.1	14.6	115

switching characteristics over recommended operating free-air temperature range, V_{CC} = 5 V \pm 0.5 V (unless otherwise noted) (see Figure 1)

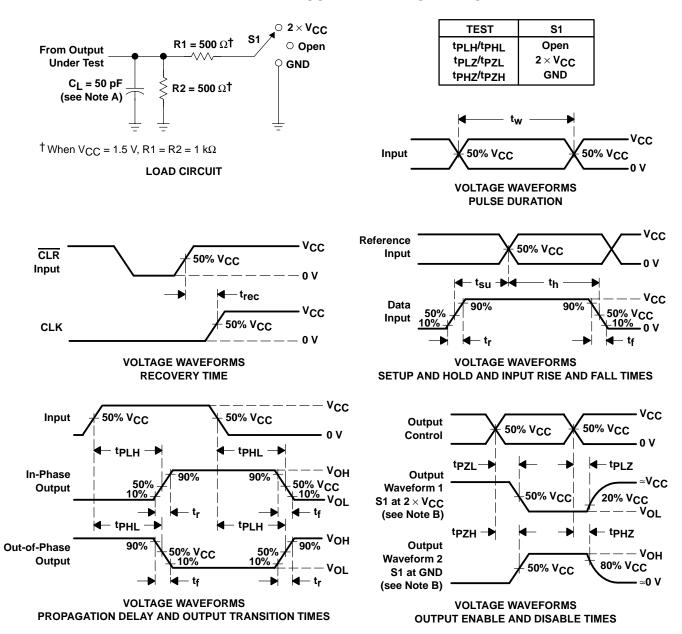
PARAMETER	FROM (INPUT)	TO (OUTPUT)		–55°C to 125°C		–40°C to 85°C	
	(1141 31)	(6611 61)	MIN	MAX	MIN	MAX	
f _{max}			110		125		MHz
tPLH	OLK.	Q or Q	2.5	10	2.6	9.1	20
t _{PHL}	CLK		2.5	10	2.6	9.1	ns
tPLH	PRE or CLR	Q or Q	2.6	10.5	2.7	9.5	nc
^t PHL	FRE OI CER	Q 01 Q	2.9	11.5	3	10.4	ns

operating characteristics, T_A = 25°C

		PARAMETER	TYP	UNIT
I	C _{pd}	Power dissipation capacitance	55	pF



PARAMETER MEASUREMENT INFORMATION



- NOTES: A. C_L includes probe and test-fixture capacitance.
 - B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
 - C. All input pulses are supplied by generators having the following characteristics: PRR \leq 1 MHz, Z_O = 50 Ω , t_Γ = 3 ns, t_f = 3 ns. Phase relationships between waveforms are arbitrary.
 - D. For clock inputs, f_{max} is measured with the input duty cycle at 50%.
 - E. The outputs are measured one at a time with one input transition per measurement.
 - F. tpLH and tpHL are the same as tpd.
 - G. tpzL and tpzH are the same as ten.
 - H. tpLz and tpHz are the same as tdis.

Figure 1. Load Circuit and Voltage Waveforms







6-Feb-2020

PACKAGING INFORMATION

Orderable Device	Status	Package Type	U		U		Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(1)		Drawing		Qty	(2)	(6)	(3)		(4/5)	
CD54AC74F3A	ACTIVE	CDIP	J	14	1	TBD	Call TI	N / A for Pkg Type	-55 to 125	CD54AC74F3A	Samples
CD74AC74E	ACTIVE	PDIP	N	14	25	Green (RoHS & no Sb/Br)	NIPDAU	N / A for Pkg Type	-55 to 125	CD74AC74E	Samples
CD74AC74M	ACTIVE	SOIC	D	14	50	Green (RoHS & no Sb/Br)	NIPDAU	Level-1-260C-UNLIM	-55 to 125	AC74M	Samples
CD74AC74M96	ACTIVE	SOIC	D	14	2500	Green (RoHS & no Sb/Br)	NIPDAU	Level-1-260C-UNLIM	-55 to 125	AC74M	Samples
CD74AC74M96E4	ACTIVE	SOIC	D	14	2500	Green (RoHS & no Sb/Br)	NIPDAU	Level-1-260C-UNLIM	-55 to 125	AC74M	Samples
CD74AC74M96G4	ACTIVE	SOIC	D	14	2500	Green (RoHS & no Sb/Br)	NIPDAU	Level-1-260C-UNLIM	-55 to 125	AC74M	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead/Ball Finish Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.



PACKAGE OPTION ADDENDUM

6-Feb-2020

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OTHER QUALIFIED VERSIONS OF CD54AC74, CD74AC74:

Military: CD54AC74

NOTE: Qualified Version Definitions:

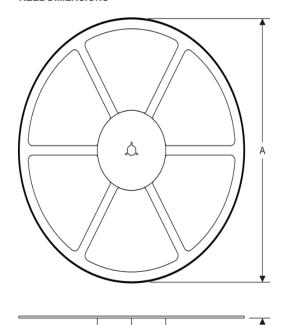
- Catalog TI's standard catalog product
- Military QML certified for Military and Defense Applications

PACKAGE MATERIALS INFORMATION

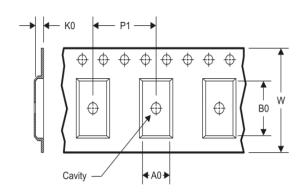
www.ti.com 14-Jul-2012

TAPE AND REEL INFORMATION

REEL DIMENSIONS



TAPE DIMENSIONS



A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

TAPE AND REEL INFORMATION

*All dimensions are nominal

Device	_	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CD74AC74M96	SOIC	D	14	2500	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1

PACKAGE MATERIALS INFORMATION

www.ti.com 14-Jul-2012



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)	
CD74AC74M96	SOIC	D	14	2500	367.0	367.0	38.0	

CERAMIC DUAL IN LINE PACKAGE



Images above are just a representation of the package family, actual package may vary. Refer to the product data sheet for package details.

4040083-5/G





CERAMIC DUAL IN LINE PACKAGE



- 1. All controlling linear dimensions are in inches. Dimensions in brackets are in millimeters. Any dimension in brackets or parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.
- 3. This package is hermitically sealed with a ceramic lid using glass frit.
- His package is remitted by sealed with a certain is using glass int.
 Index point is provided on cap for terminal identification only and on press ceramic glass frit seal only.
 Falls within MIL-STD-1835 and GDIP1-T14.



CERAMIC DUAL IN LINE PACKAGE



D (R-PDSO-G14)

PLASTIC SMALL OUTLINE



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AB.



D (R-PDSO-G14)

PLASTIC SMALL OUTLINE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



N (R-PDIP-T**)

PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- The 20 pin end lead shoulder width is a vendor option, either half or full width.



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